

# FGH20N60UFD 600 V, 20 A Field Stop IGBT

### Features

- High Current Capability
- Low Saturation Voltage: V<sub>CE(sat)</sub> =1.8 V @ I<sub>C</sub> = 20 A
- High Input Impedance
- Fast Switching
- RoHS Compliant

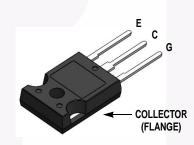
## Applications

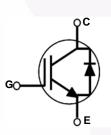
• Solar Inverter, UPS, Welder, PFC

March 2015

# **General Description**

Using novel field stop IGBT technology, Fairchild's field stop IGBTs offer the optimum performance for solar inverter, UPS, welder and PFC applications where low conduction and switching losses are essential.





### **Absolute Maximum Ratings**

| Symbol                                   | Description   | Ratings                              | Unit |   |
|--|---|--------------------------------------|------|---|
| V <sub>CES</sub>                         | Collector to Emitter Voltage  | 600                                  | V    |   |
| V  | Gate to Emitter Voltage   | ±20                                  | V    |   |
| V <sub>GES</sub>                         | Transient Gate-to-Emitter Voltage   | ±30                                  | V    |   |
| I <sub>C</sub>                           | Collector Current   | @ T <sub>C</sub> = 25°C              | 40   | A |
| 'U                                       | Collector Current   | 20                                   | А    |   |
| I <sub>CM (1)</sub>                      | Pulsed Collector Current@ $T_C = 25^{\circ}C$                             |                                      | 60   | А |
| IF                                       | Diode Forward Current   | @ T <sub>C</sub> = 25 <sup>o</sup> C | 20   | А |
| 'F                                       | Diode Forward Current   | 10                                   | А    |   |
| I <sub>FM (1)</sub>                      | Pulsed Diode Maximum Forward Cu   | 60                                   | А    |   |
| P <sub>D</sub> Maximum Power Dissipation |   | @ T <sub>C</sub> = 25 <sup>o</sup> C | 165  | W |
| . D                                      | Maximum Power Dissipation   | @ T <sub>C</sub> = 100°C             | 66   | W |
| TJ                                       | Operating Junction Temperature  | -55 to +150                          | °C   |   |
| T <sub>stg</sub>                         | Storage Temperature Range   | -55 to +150                          | °C   |   |
| Τ <sub>L</sub>                           | Maximum Lead Temp. for soldering<br>Purposes, 1/8" from case for 5 second | 300                                  | °C   |   |

Notes:

1: Repetitive rating: Pulse width limited by max. junction temperature

| Part Nu                               | Part Number Top Mark Package |                      | Packing Method | Reel Size   | Т          | ape Wid | lth Q | Quantity |      |
|---------------------------------------|------------------------------|----------------------|----------------|---|------------|---------|-------|----------|------|
| FGH20N60UFDTU FGH20N60UFD TO-247      |                              |                      | Tube           | N/A   |            | N/A     |       | 30       |      |
| Electric                              | al Ch                        | aracteristics        | s of the IC    | <b>GBT</b> $T_{C} = 25^{\circ}C$ unless other                                   | wise noted |         |       |          |      |
| Symbol                                |                              | Parameter            | •              | Test Conditio   | ns M       | in.     | Тур.  | Max.     | Unit |
| -                                     | Ļ                            |                      |                |   |            |         | ļ     |          |      |
| Off Charac                            | 1                            |                      |                |   |            |         |       |          |      |
| BV <sub>CES</sub>                     |                              | or to Emitter Breako | -              | $V_{GE} = 0 V, I_{C} = 250 \mu A$   |            | 00      | -     | -        | V    |
| $\Delta BV_{CES}$<br>/ $\Delta T_{J}$ | Temper<br>Voltage            | ature Coefficient of | Breakdown      | $V_{GE} = 0 \text{ V}, \text{ I}_{C} = 250 \mu\text{A}$                         |            | -       |       | -        | V/ºC |
| I <sub>CES</sub>                      | Collecto                     | or Cut-Off Current   |                | $V_{CE} = V_{CES}, V_{GE} = 0 V$  |            | -       |       | 250      | μA   |
| I <sub>GES</sub>                      | G-E Le                       | akage Current        |                | $V_{GE} = V_{GES}, V_{CE} = 0 V$  |            |         |       | ±400     | nA   |
| On Charac                             | teristics                    |                      |                |   |            |         |       |          |      |
| V <sub>GE(th)</sub>                   | 1                            | reshold Voltage      |                | I <sub>C</sub> = 250 μA, V <sub>CE</sub> = V <sub>GE</sub>                      | 4          | .0      | 5.0   | 6.5      | V    |
| 0=(11)                                |                              | 5                    |                | $I_{\rm C} = 20$ A, $V_{\rm GF} = 15$ V   |            | -       | 1.8   | 2.4      | V    |
| V <sub>CE(sat)</sub>                  | Collecto                     | or to Emitter Satura | tion Voltage   | $I_{C} = 20 \text{ A}, V_{GE} = 15 \text{ V},$<br>$T_{C} = 125^{\circ}\text{C}$ |            | -       | 2.0   | -        | V    |
|                                       |                              |                      |                |   |            |         |       |          |      |
| Dynamic C                             | 1                            |                      |                |   |            |         | 0.40  | _        | ~    |
| C <sub>ies</sub>                      | -                            | apacitance           |                | V <sub>CE</sub> = 30 V, V <sub>GE</sub> = 0 V,                                  |            | -       | 940   | -        | pF   |
| C <sub>oes</sub>                      | -                            |                      |                | f = 1 MHz   |            | -       | 110   | -        | pF   |
| C <sub>res</sub>                      | Revers                       | e Transfer Capacita  | ance           |   |            | -       | 40    | -        | pF   |
| Switching                             | Charact                      | eristics             |                |   |            |         |       |          |      |
| t <sub>d(on)</sub>                    | Turn-On Delay Time           |                      |                |   | -          | 13      | -     | ns       |      |
| t <sub>r</sub>                        | Rise Ti                      | Rise Time            |                | -   |            | -       | 17    | -        | ns   |
| t <sub>d(off)</sub>                   | Turn-O                       | ff Delay Time        |                | V <sub>CC</sub> = 400 V, I <sub>C</sub> = 20 A,                                 |            | -       | 87    | -        | ns   |
| t <sub>f</sub>                        | Fall Tim                     |                      |                | $R_G = 10 \Omega$ , $V_{GE} = 15 V$ ,<br>Inductive Load, $T_C = 25^{\circ}C$    |            | -       | 32    | 64       | ns   |
| Eon                                   | Turn-O                       |                      |                |   |            | -       | 0.38  | -        | mJ   |
| E <sub>off</sub>                      | Turn-O                       | ff Switching Loss    |                |   |            | -       | 0.26  | -        | mJ   |
| E <sub>ts</sub>                       | Total Sv                     | witching Loss        |                | -   |            | - /     | 0.64  | -        | mJ   |
| t <sub>d(on)</sub>                    | Turn-O                       | n Delay Time         |                |   |            | _       | 13    | - /      | ns   |
| t <sub>r</sub>                        | Rise Ti                      | me                   |                |   |            | -       | 16    | -        | ns   |
| t <sub>d(off)</sub>                   | Turn-O                       | ff Delay Time        |                | V <sub>CC</sub> = 400 V, I <sub>C</sub> = 20 A,                                 |            | -       | 92    | -        | ns   |
| t <sub>f</sub>                        | Fall Tim                     | ne                   |                | $R_{G} = 10 \Omega$ , $V_{GE} = 15 V$ ,   | -0.0       | -       | 63    | -        | ns   |
| E <sub>on</sub>                       | Turn-O                       | n Switching Loss     |                | Inductive Load, T <sub>C</sub> = 125  | 5.6        | -       | 0.41  | - /      | mJ   |
| E <sub>off</sub>                      | Turn-O                       | ff Switching Loss    |                |   |            | -       | 0.36  | -        | mJ   |
| E <sub>ts</sub>                       | Total Sv                     | witching Loss        |                |   |            | -       | 0.77  | - \      | mJ   |
| Qg                                    | Total G                      | ate Charge           |                |   |            | -       | 63    | -        | nC   |
| Q <sub>ge</sub>                       | Gate to                      | Emitter Charge       |                | $V_{CE} = 400 \text{ V}, I_{C} = 20 \text{ A},$                                 |            | -       | 7     | -        | nC   |
| Q <sub>gc</sub>                       | Gate to                      | Collector Charge     |                | V <sub>GE</sub> = 15 V  |            | -       | 32    |          | nC   |

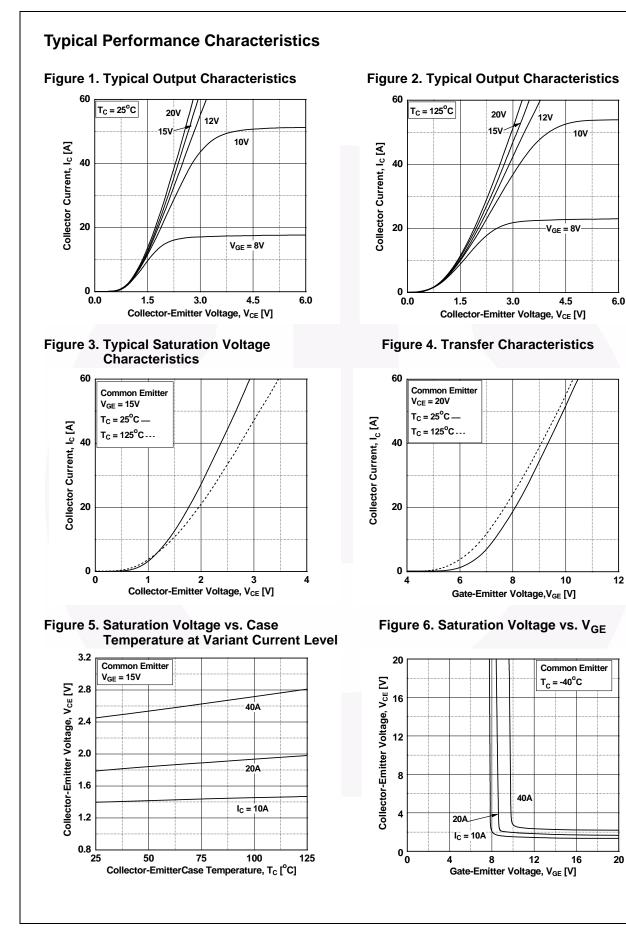
# **Thermal Characteristics**

| Symbol                  | Parameter                               | Тур. | Max. | Unit |  |
|-------------------------|---|------|------|------|--|
| $R_{\theta JC}(IGBT)$   | Thermal Resistance, Junction to Case    | -    | 0.76 | °C/W |  |
| $R_{\theta JC}$ (Diode) | Thermal Resistance, Junction to Case    | -    | 2.51 | °C/W |  |
| $R_{	extsf{	heta}JA}$   | Thermal Resistance, Junction to Ambient | -    | 40   | °C/W |  |

# Electrical Characteristics of the Diode $T_{C} = 25^{\circ}C$ unless otherwise noted

| Symbol          | Parameter                     |                       | Test Condition                                       | ns                     | Min. | Тур. | Max | Unit |
|-----------------|-------------------------------|-----------------------|--|------------------------|------|------|-----|------|
| V <sub>FM</sub> | Diode Forward Voltage         | I <sub>E</sub> = 10 A | $T_{\rm C} = 25^{\rm o}{\rm C}$                      | -                      | 1.9  | 2.5  | V   |      |
| · FIM           | Diodo i ormana voltago        |                       |  | $T_{C} = 125^{\circ}C$ | -    | 1.7  | -   |      |
| t               | Diode Reverse Recovery Time   |                       | $T_C = 25^{\circ}C$                                  | -                      | 34   | -    | ns  |      |
| ۲r              |                               |                       | I <sub>F</sub> =10 A, di <sub>F</sub> /dt = 200 A/μs | $T_{C} = 125^{\circ}C$ | -    | 57   |     | -    |
| Q <sub>rr</sub> | Diode Reverse Recovery Charge |                       | $T_C = 25^{\circ}C$                                  | -                      | 41   | -    | nC  |      |
| -11             |                               |                       |  | $T_{C} = 125^{\circ}C$ | -    | 96   | -   |      |

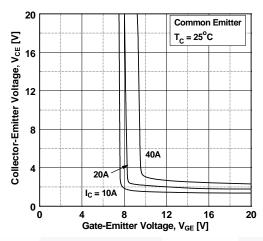
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# **Typical Performance Characteristics**

Figure 7. Saturation Voltage vs. V<sub>GE</sub>



**Figure 9. Capacitance Characteristics** 

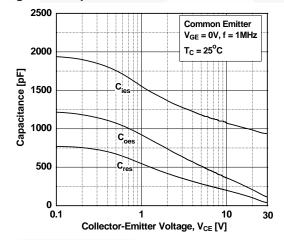


Figure 11. SOA Characteristics

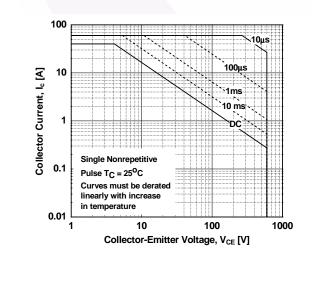


Figure 8. Saturation Voltage vs. V<sub>GE</sub>

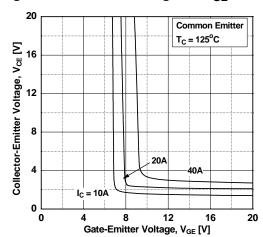


Figure 10. Gate charge Characteristics

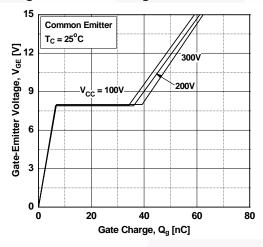
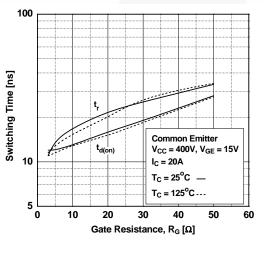
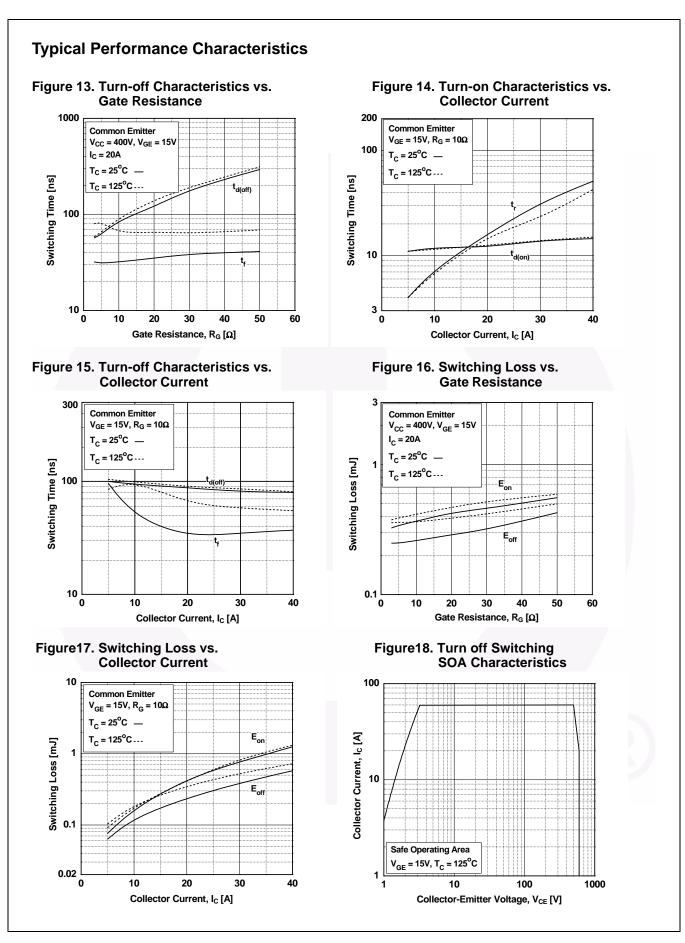
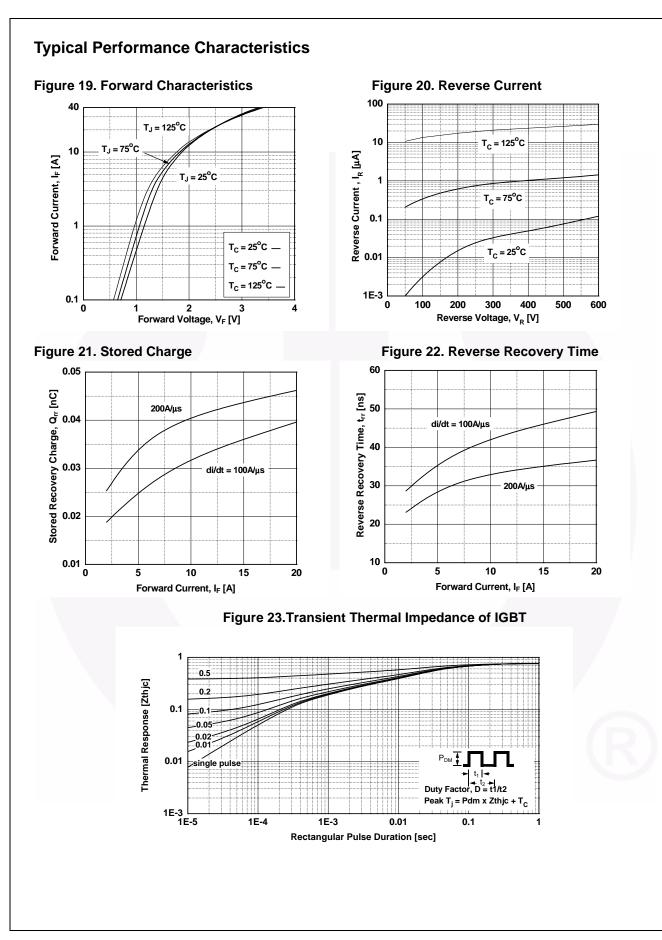


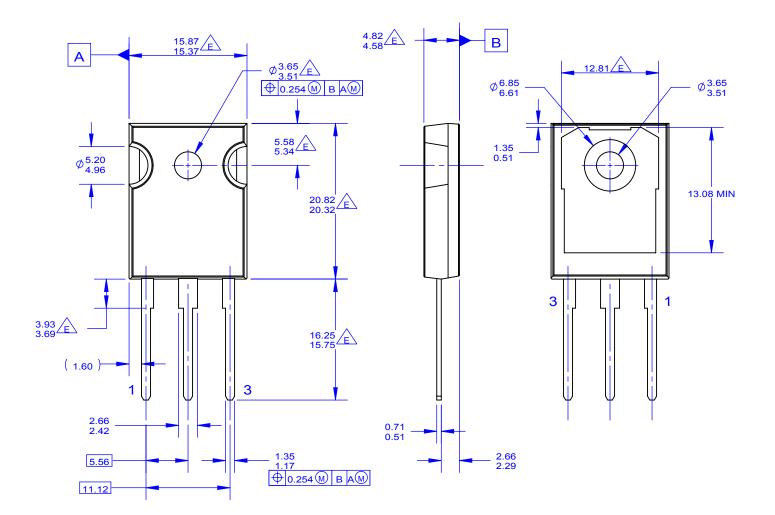
Figure 12. Turn-on Characteristics vs. Gate Resistance





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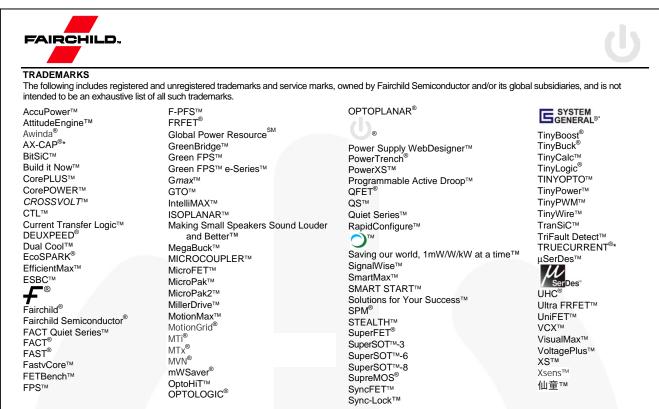




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